



ITW

Docket No.: H6808.0002/P002-A
(PATENT)

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Tohru Ishitani et al.

Application No.: 10/803,932

Confirmation No.: 6731

Filed: March 19, 2004

Art Unit: 2858

For: APPARATUS FOR INSPECTING DEFECTS OF DEVICES AND METHOD OF INSPECTING DEFECTS

Examiner: J. Teresinski

RESPONSE TO RESTRICTION REQUIREMENT

MS Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

In response to the Office Action dated August 12, 2004 (Paper No. 20040809), Applicant elects Group I (claims 11-17).

This election is made with traverse. M.P.E.P. § 803 provides as follows: "If the search and examination of an entire application can be made without serious burden, the examiner must examine it on the merits, even though it includes claims to independent or distinct inventions." Applicant respectfully submits that other claims in this case can be examined together with claims 11-17 without "serious burden."

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Favorable action on the application is solicited.

Dated: September 13, 2004

Respectfully submitted,

By 

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